

<b>Notice of References Cited</b>	Application/Control No. 09/714,317	Applicant(s)/Patent Under Reexamination TAKAKU ET AL.	
	Examiner Christopher B Shin	Art Unit 2182	Page 1 of 1

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	C	US-6,360,287	03-2002	Kawamura, Harumi	710/61
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	L	US-			
	M	US-			

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